

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10727039	CHEN ET AL.
Examiner	Art Unit	
Lee, John W	2624	

SEARCHED

Class	Subclass	Date	Examiner
348	241	06/14/2007	John W. Lee

SEARCH NOTES

Search Notes	Date	Examiner
Inventor Search	06/14/2007	John W. Lee
EAST Search	06/14/2007	John W. Lee
EAST Search	10/29/2007	John W. Lee

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner